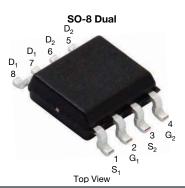


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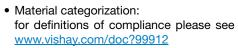
# Complementary (N- and P-Channel) MOSFET



PRODUCT SUMMARY							
	N-CHANNEL	P-CHANNEL					
V <sub>DS</sub> (V)	30	-8					
$R_{DS(on)}(\Omega)$ at $V_{GS} = \pm 10 \text{ V}$	0.017	0.027					
$R_{DS(on)}(\Omega)$ at $V_{GS} = \pm 4.5 \text{ V}$	0.020	0.037					
Q <sub>g</sub> typ. (nC)	7.9	16.5					
I <sub>D</sub> (A) <sup>a</sup>	12	-8					
Configuration	N- and p-pair						

### **FEATURES**

- TrenchFET® power MOSFET
- 100 % R<sub>g</sub> and UIS tested

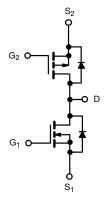




ROHS COMPLIANT HALOGEN FREE

### **APPLICATIONS**

- Level shift
- · Load switch



ORDERING INFORMATION	
Package	SO-8
Lead (Pb)-free and halogen-free	Si4501BDY-T1-GE3

ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT			
Drain-source voltage	V <sub>DS</sub>	30	-8	V			
Gate-source voltage		$V_{GS}$	± 20	± 8	V		
	T <sub>C</sub> = 25 °C		12	-8			
Continuous drain current (T, I = 150 °C)	T <sub>C</sub> = 70 °C		9.5	-6.4			
Continuous drain current (1) = 150 °C)	T <sub>A</sub> = 25 °C	l <sub>D</sub>	9 b, c	-6.4 b, c			
	T <sub>A</sub> = 70 °C		7.2 b, c	-5.1 <sup>b, c</sup>			
Pulsed drain current (10 µs pulse width)		I <sub>DM</sub>	40	-40	Α		
Source-drain current diode current	T <sub>C</sub> = 25 °C		4	-2.8			
Source-drain current diode current	T <sub>A</sub> = 25 °C	l <sub>S</sub>	2.2 b, c	-1.8 <sup>b, c</sup>			
Pulsed source-drain current		I <sub>SM</sub>	40	-40			
Single pulse avalanche current	L = 0.1 mH	I <sub>AS</sub>	5	-5			
Single pulse avalanche energy	L = U. I IIII	E <sub>AS</sub>	1.25	1.25	mJ		
	T <sub>C</sub> = 25 °C		4.5	3.1			
Mayimum nausar disainatian	T <sub>C</sub> = 70 °C		2.8	2	١٨/		
Maximum power dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.5 b, c	2 b, c	W		
	T <sub>A</sub> = 70 °C		1.6 <sup>b, c</sup>	1.28 <sup>b, c</sup>			
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to	+150	°C		

THERMAL RESISTANCE RATINGS							
			N-CH/	ANNEL	P-CH/	ANNEL	
PARAMETER		SYMBOL	TYP.	MAX.	TYP.	MAX.	UNIT
Maximum junction-to-ambient b, d	t ≤ 10 s	R <sub>thJA</sub>	40	50	52	62.5	°C/W
Maximum junction-to-foot (Drain)	Steady state	$R_{thJF}$	22	28	32	40	C/VV

### Notes

- a. Based on  $T_C = 25 \, ^{\circ}C$
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s
- d. Maximum under steady state conditions is 95 °C/W (N-Channel) and 110 °C/W (P-Channel)



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PARAMETER	METER SYMBOL TEST CONDITIONS		MIN.	TYP. a	MAX.	UNIT				
Static	·				ı		<u> </u>			
Duning and the second s		$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	N-Ch	30	-	-				
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250 μA	P-Ch	-8	-	-	V			
V tomoroustino coefficient	A) / /T	I <sub>D</sub> = 250 μA	N-Ch	-	34	-				
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = -250 μA	P-Ch	-	-3	-				
V tompovetive coefficient	A)/ /T	I <sub>D</sub> = 250 μA	N-Ch	-	-4.5	-	mV/°C			
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = -250 μA	P-Ch	-	2.6	-	1			
Cata thurs he also walte as		$V_{DS} = V_{GS}, I_D = 250 \mu A$	N-Ch	0.8	-	2	1			
Gate threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	P-Ch	-0.45	-	-0.9	V			
Oak had had a		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	N-Ch	-	-	± 100	1 .			
Gate-body leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	P-Ch	-	-	± 100	nA			
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	N-Ch	-	-	1				
		$V_{DS} = -8 \text{ V}, V_{GS} = 0 \text{ V}$	P-Ch	-	-	-1				
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	N-Ch	-	-	5	μA			
		V <sub>DS</sub> = -8 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	P-Ch	-	-	-5	1			
On-state drain current <sup>b</sup>		V <sub>DS</sub> = 5 V, V <sub>GS</sub> = 10 V	N-Ch	20	-	-	<u> </u>			
	I <sub>D(on)</sub>	$V_{DS} = -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	P-Ch	-20	-	-	Α			
Drain-source on-state resistance <sup>b</sup>		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A	N-Ch	-	0.0135	0.0170	Ω			
		$V_{GS} = -4.5 \text{ V}, I_D = -6 \text{ A}$	P-Ch	-	0.0210	0.0270				
	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$	N-Ch	-	0.0160	0.0200				
		$V_{GS} = -2.5 \text{ V}, I_D = -5 \text{ A}$	P-Ch	-	0.0290	0.0370				
		V <sub>DS</sub> = 15 V, I <sub>D</sub> = 10 A	N-Ch	-	29	-	_			
Forward transconductance b g <sub>fs</sub>		V <sub>DS</sub> = -15 V, I <sub>D</sub> = -6 A P-Ch			24	-	S			
Dynamic <sup>a</sup>		-				·				
Inn. t annaitena	0		N-Ch	-	805	-				
Input capacitance	C <sub>iss</sub>	N-Channel	P-Ch	-	1400	-	1			
0.1-1		$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ N-C		-	170	-	1 _			
Output capacitance	C <sub>oss</sub>	P-Channel	P-Ch	-	660	-	- pF			
Daniel transfer constitution	0	$V_{DS} = -4 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	N-Ch	-	80	-				
Reverse transfer capacitance	se transfer capacitance C <sub>rss</sub>		P-Ch	-	630	-	1			
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$	N-Ch	-	16.5	25				
Total gate charge		$V_{DS} = -4 \text{ V}, V_{GS} = -8 \text{ V}, I_{D} = -6 \text{ A}$	P-Ch	-	27.5	42				
	Qg		N-Ch	-	7.9	12				
		N-Channel	P-Ch	-	16.5	25				
Gate-source charge		$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$	N-Ch	-	2.2	-	nC			
	$Q_{gs}$	P-Channel	P-Ch	-	2.2	-	1			
		$V_{DS} = -4 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -6 \text{ A}$	N-Ch	-	2.7	-				
Gate-drain charge	$Q_{gd}$		P-Ch	-	4.8	-				
_			N-Ch	0.3	1.1	2.2				
Gate resistance	$R_g$	f = 1 MHz	P-Ch	0.9	4.2	8.4	Ω			

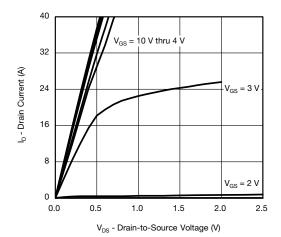


PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP. a	MAX.	UNIT
Dynamic <sup>a</sup>	'						
Turn-on delay time	t <sub>d(on)</sub>		N-Ch	-	7	14	
	-d(on)	N-Channel	P-Ch	-	6	12	
Rise time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_L = 3 \Omega$	N-Ch	-	11	22	
	'	$I_D \cong 5 \text{ Å}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	P-Ch	-	12	24	
Turn-off delay time	t <sub>d(off)</sub>	P-Channel	N-Ch	-	15	30	
	, ,	$V_{DD}$ = -4 V, $R_L$ = 0.8 $\Omega$ $I_D \cong$ -5 A, $V_{GEN}$ = -10 V, $R_q$ = 1 $\Omega$	P-Ch	-	35	65	
Fall time	t <sub>f</sub>	D ALIV , g	N-Ch P-Ch	-	8	16 18	
			N-Ch	_	16	30	ns
Turn-on delay time	t <sub>d(on)</sub>		P-Ch		22	40	
		N-Channel $V_{DD} = 15 \text{ V}, R_{L} = 3 \Omega$	N-Ch	-	55	100	
Rise time	t <sub>r</sub>	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	P-Ch	-	18	35	
		P-Channel	N-Ch	_	22	40	
Turn-off delay time	t <sub>d(off)</sub>	$V_{DD} = -4 \text{ V}, R_L = 0.8 \Omega$	P-Ch	-	34	65	
E-III Co.		$I_D \cong -5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	N-Ch	-	10	20	
Fall time	t <sub>f</sub>		P-Ch	-	14	28	
<b>Drain-Source Body Diode Characterist</b>	cs						
Continuous source-drain diode current	Is	T <sub>C</sub> = 25 °C	N-Ch	-	-	4	
Continuous source drain aloue carron	'5	16 - 23 - 3	P-Ch	-	-	-2.8	A
Pulse diode forward current <sup>a</sup>	I <sub>SM</sub>		N-Ch	-	-	40	
	0		P-Ch	-	-	-40	
Body diode voltage	V <sub>SD</sub>	I <sub>S</sub> = 2 A	N-Ch	-	0.72	1.1	V
		I <sub>S</sub> = -2 A	P-Ch	-	-0.71 14	-1.1 28	
Body diode reverse recovery time	t <sub>rr</sub>		N-Ch P-Ch	-	49	98	ns
		N-Channel	N-Ch	_	5.5	11	
Body diode reverse recovery charge	Q <sub>rr</sub>	$I_F = 1.8 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s,}$ $T_J = 25 \text{ °C}$		_	47	94	nC
			P-Ch N-Ch	_	7.5	-	
Reverse recovery fall time	t <sub>a</sub>	P-Channel $I_F = -1.8 \text{ A, di/dt} = -100 \text{ A/}\mu\text{s,}$	P-Ch	_	26	-	1
		T <sub>J</sub> = 25 °C		_	6.5	-	ns
Reverse recovery rise time	t <sub>b</sub>			_	23	_	1

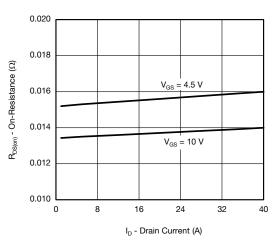
- a. Guaranteed by design, not subject to production testing
- b. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

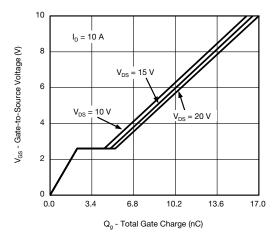




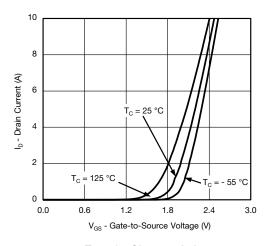
### **Output Characteristics**



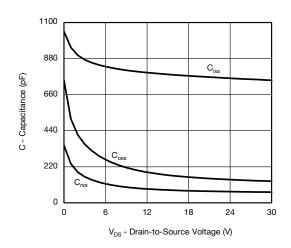
### On-Resistance vs. Drain Current and Gate Voltage



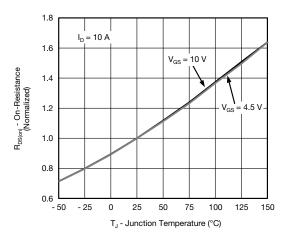
**Gate Charge** 



### **Transfer Characteristics**

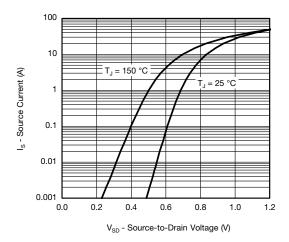


### Capacitance

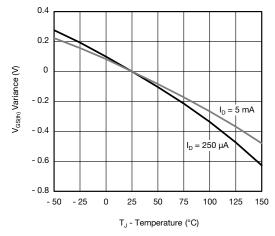


On-Resistance vs. Junction Temperature

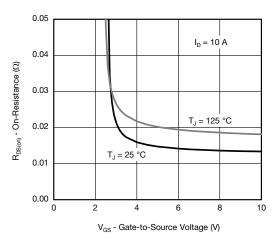




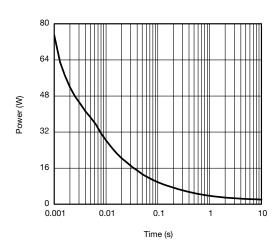
### Source-Drain Diode Forward Voltage



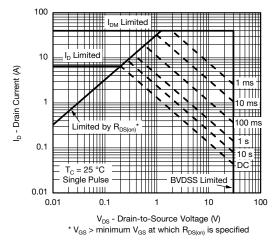
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

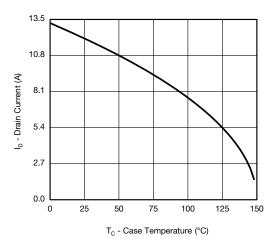


Single Pulse Power, Junction-to-Ambient

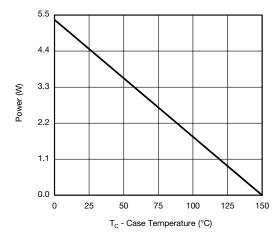


Safe Operating Area, Junction-to-Ambient

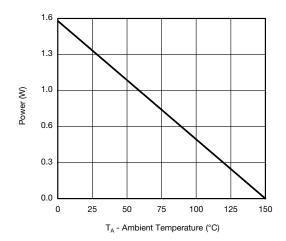




### Current Derating a





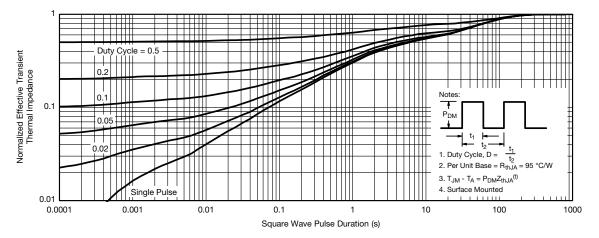


Power Derating, Junction-to-Ambient

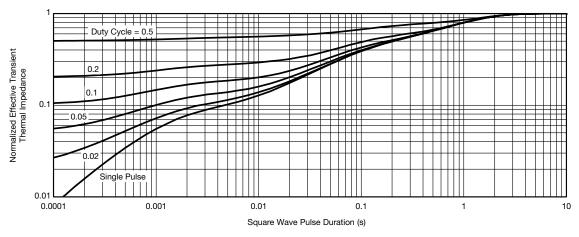
### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



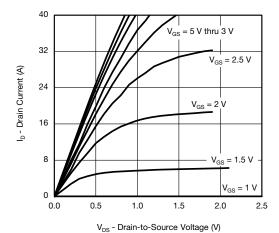


Normalized Thermal Transient Impedance, Junction-to-Ambient

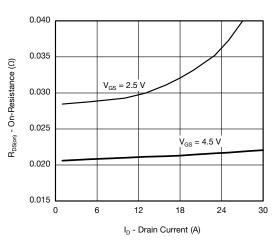


Normalized Thermal Transient Impedance, Junction-to-Foot

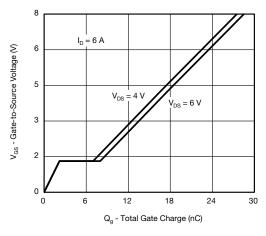




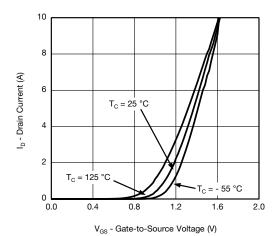
### **Output Characteristics**



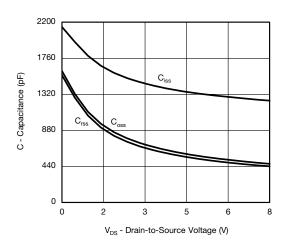
### On-Resistance vs. Drain Current and Gate Voltage



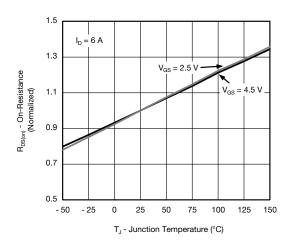
Gate Charge



**Transfer Characteristics** 

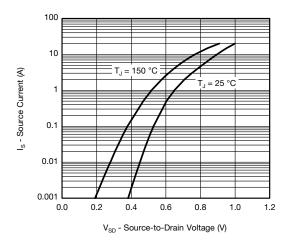


Capacitance

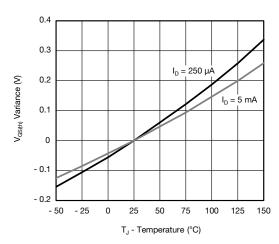


On-Resistance vs. Junction Temperature

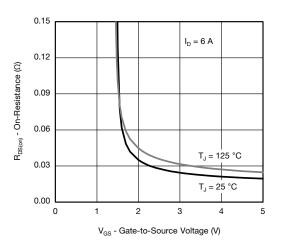




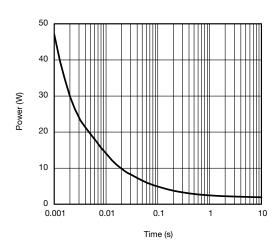
### Source-Drain Diode Forward Voltage



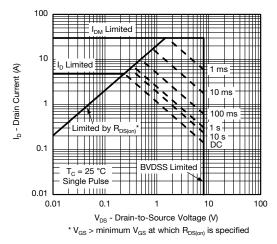
**Threshold Voltage** 



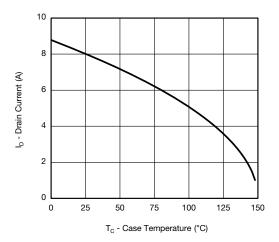
On-Resistance vs. Gate-to-Source Voltage



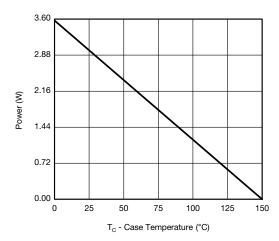
Single Pulse Power, Junction-to-Ambient



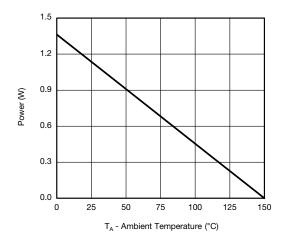
Safe Operating Area, Junction-to-Ambient



### Current Derating a





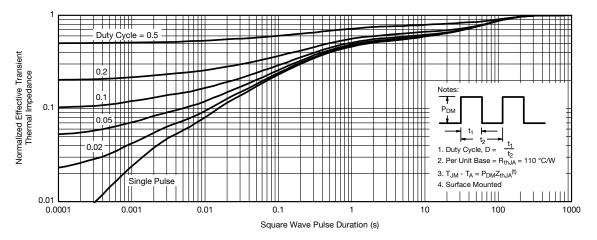


Power Derating, Junction-to-Ambient

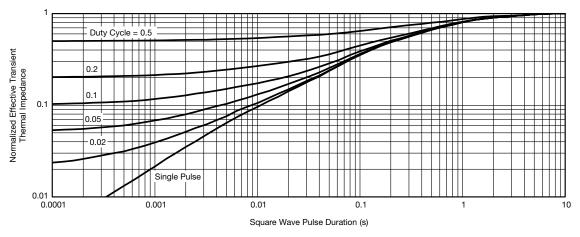
### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



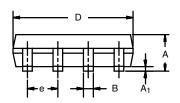
Normalized Thermal Transient Impedance, Junction-to-Foot

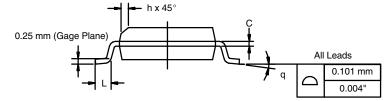
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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES					
DIM	Min	Max	Min	Max				
Α	1.35	1.75	0.053	0.069				
A <sub>1</sub>	0.10	0.20	0.004	0.008				
В	0.35	0.51	0.014	0.020				
С	0.19	0.25	0.0075	0.010				
D	4.80	5.00	0.189	0.196				
Е	3.80	4.00	0.150	0.157				
е	1.27	BSC	0.050 BSC					
Н	5.80	6.20	0.228	0.244				
h	0.25	0.50	0.010	0.020				
L	0.50	0.93	0.020	0.037				
q	0°	8°	0°	8°				
S	0.44	0.64	0.018	0.026				
ECN: C-0652	ECN: C-06527-Rev. I. 11-Sep-06							

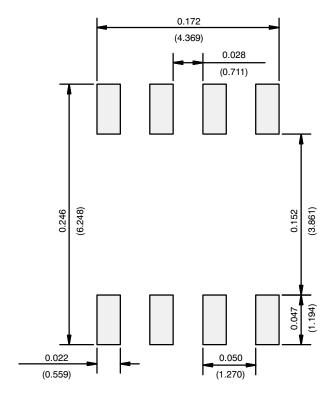
DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06

# APPLICATION NOTE



### **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)

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